

Search Notes

Application/Control No.

10/690,324

Examiner

MARK MAIS

Applicant(s)/Patent under
Reexamination

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Art Unit

2419

SEARCHED

Class	Subclass	Date	Examiner
370	535 536		
	537 539		
	540 541		
	542 544	9/9/2009	MAM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See Inventorship Search/See Attached Electronic Search	3/4/2008	MAM
See Attached Electronic Search [updated]	9/22/2008	MAM
See Attached Electronic Search [updated]	1/22/2009	MAM
See Attached Electronic Search [updated]	9/9/2009	MAM